Se	Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/402,144	HANCK ET AL.	
Examiner	Art Unit	
Jung Kim	2132	

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01	1	<u> </u>	Examiner	
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713	161,170, 181	8/18/2006	JK	
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see enclosed search history		